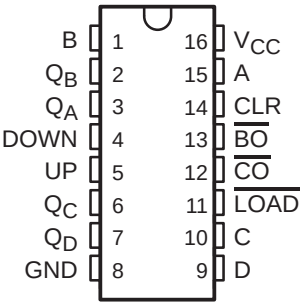
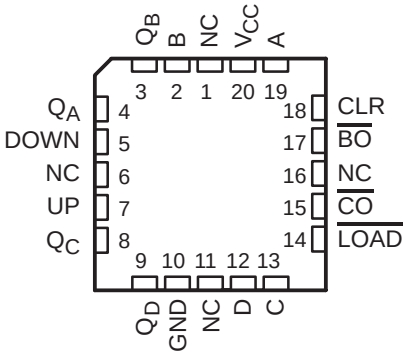
- **Look-Ahead Circuitry Enhances Cascaded Counters**
- **Fully Synchronous in Count Modes**
- **Parallel Asynchronous Load for Modulo-N Count Lengths**
- **Asynchronous Clear**
- **Package Options Include Plastic Small-Outline (D) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs**

SN54ALS193A . . . J PACKAGE
SN74ALS193A . . . D OR N PACKAGE
(TOP VIEW)



SN54ALS193A . . . FK PACKAGE
(TOP VIEW)



NC – No internal connection

description

The ’ALS193A are synchronous, reversible, 4-bit up/down binary counters. Synchronous counting operation is provided by having all flip-flops clocked simultaneously so that the outputs change coincident with each other when instructed by the steering logic. This mode of operation eliminates the output counting spikes normally associated with asynchronous (ripple-clock) counters.

The outputs of the four flip-flops are triggered on a low-to-high-level transition of either count/clock (UP or DOWN) input. The direction of the count is determined by which count input is pulsed while the other count input is high.

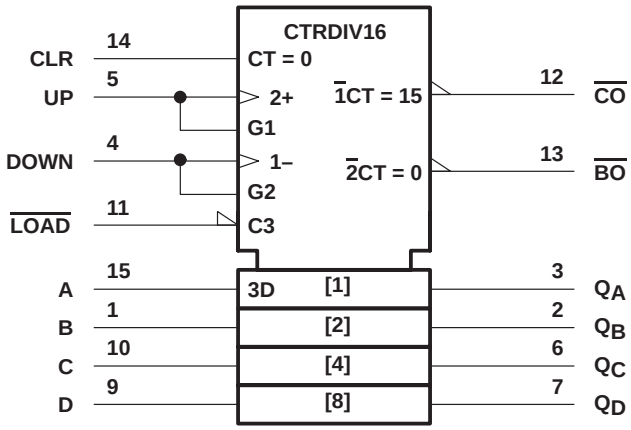
All four counters are fully programmable; that is, each output may be preset to either level by placing a low on the load ($\overline{\text{LOAD}}$) input and entering the desired data at the data inputs. The output changes to agree with the data inputs independently of the count pulses. This feature allows the counters to be used as modulo-N dividers by simply modifying the count length with the preset inputs.

A high level applied to the clear (CLR) input forces all outputs to the low level. The clear function is independent of the count and $\overline{\text{LOAD}}$ inputs. The UP, DOWN, and $\overline{\text{LOAD}}$ inputs are buffered to lower the drive requirement, which significantly reduces the loading on, or current required by, clock drivers, etc., for long parallel words.

These counters are designed to be cascaded without the need for external circuitry. The borrow ($\overline{\text{BO}}$) output produces a low-level pulse while the count is zero (all Q outputs low) and the DOWN input is low. Similarily, the carry ($\overline{\text{CO}}$) output produces a low-level pulse while the count is 9 or 15 (all Q outputs high) and the UP input is low. The counters can then be easily cascaded by feeding $\overline{\text{BO}}$ and $\overline{\text{CO}}$ to the count-down and count-up inputs, respectively, of the succeeding counter.

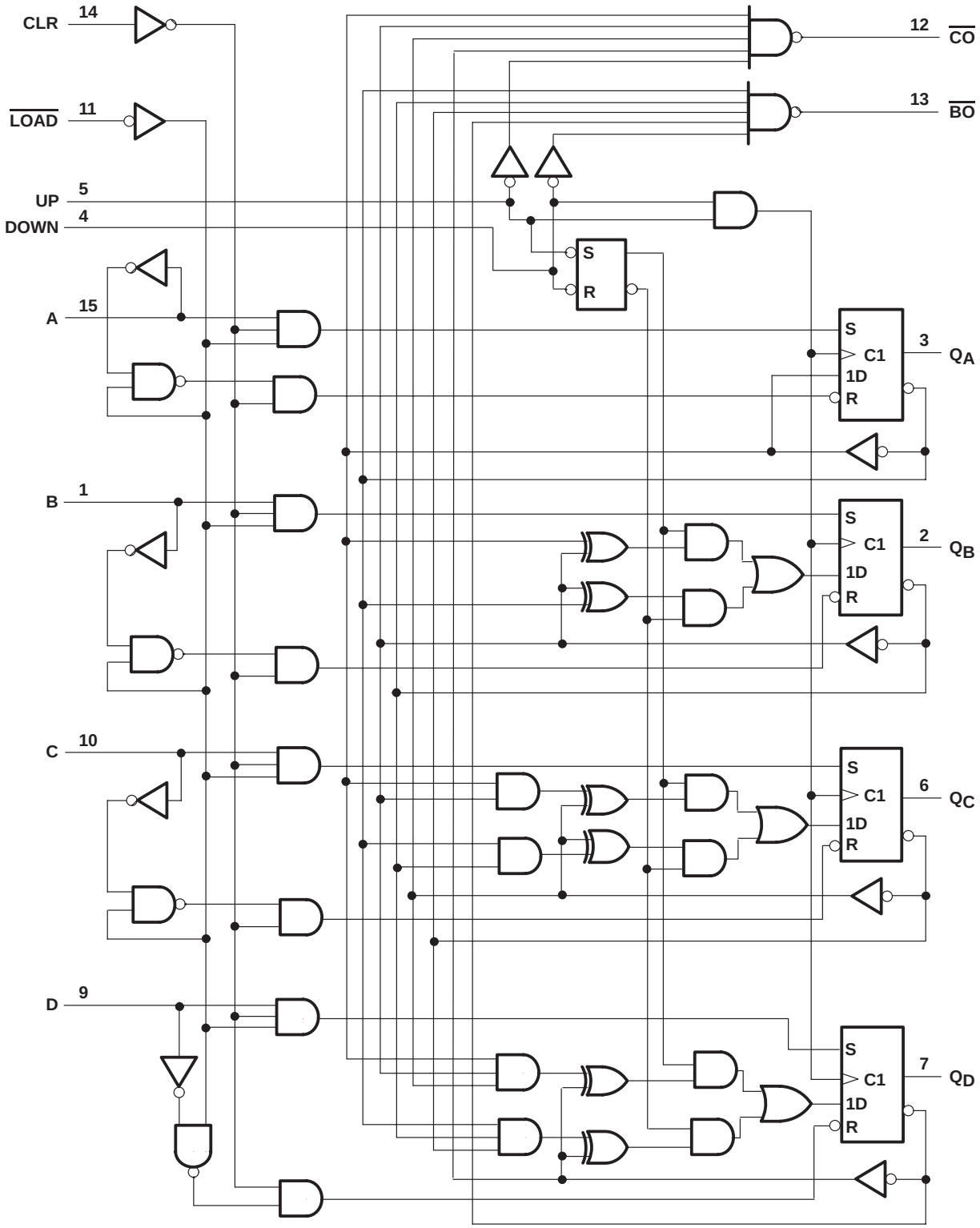
The SN54ALS193A is characterized for operation over the full military temperature range of –55°C to 125°C. The SN74ALS193A is characterized for operation from 0°C to 70°C.

logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.
Pin numbers shown are for the D, J, and N packages.

logic diagram (positive logic)

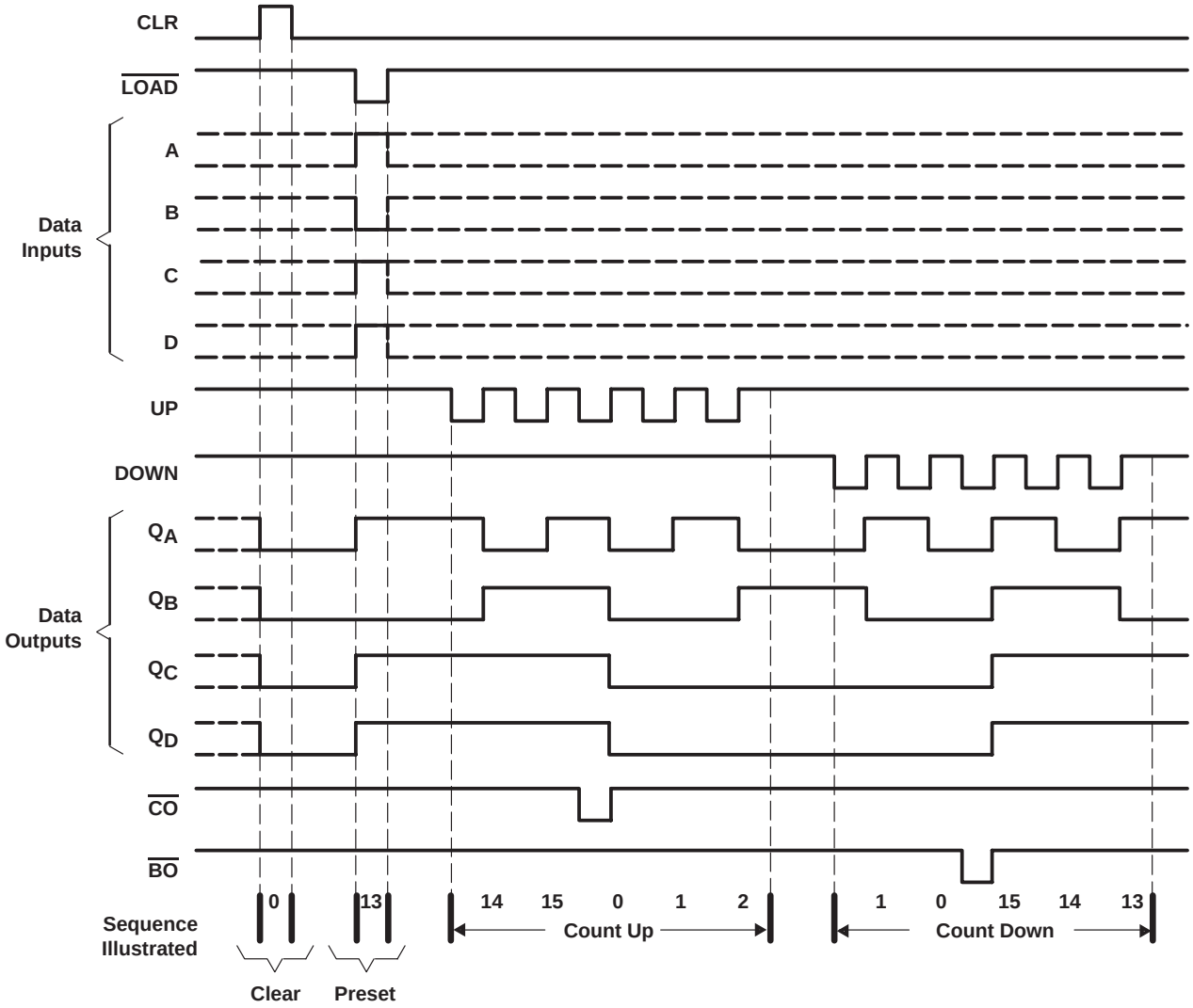


Pin numbers shown are for the D, J, and N packages.

typical clear, load, and count sequence

the following sequence is illustrated below:

1. Clear outputs to zero
2. Load (preset) to binary 13
3. Count up to 14, 15 (carry), 0, 1, and 2
4. Count down to 1, 0 (borrow), 15, 14, and 13



NOTES: A. Clear overrides load, data, and count inputs.
B. When counting up, count-down input must be high; when counting down, count-up input must be high.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V_{CC} . . . . . 7 V
Input voltage, V_I . . . . . 7 V
Operating free-air temperature range, T_A: SN54ALS193A . . . . . –55°C to 125°C
SN74ALS193A . . . . . 0°C to 70°C
Storage temperature range, T_{stg} . . . . . –65°C to 150°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

			SN54ALS193A			SN74ALS193A			UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage		4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage		2			2			V
V_{IL}	Low-level input voltage				0.7			0.8	V
I_{OH}	High-level output current				–0.4			–0.4	mA
I_{OL}	Low-level output current				4			8	mA
f_{clock}	Clock frequency		0		20	0		30	MHz
t_w	Pulse duration	CLR high	10			10			ns
		$\overline{LOAD}$ low	25			20			
		UP or DOWN high or low	30			16.5			
t_{su}	Setup time	Data before $\overline{LOAD}\uparrow$	25			20			ns
		CLR inactive before UP or DOWN	20			20			
		$\overline{LOAD}$ inactive before UP or DOWN	20			20			
t_h	Hold time	Data after $\overline{LOAD}\uparrow$	5			5			ns
		UP high after DOWN$\uparrow$	5			0			
		DOWN high after UP$\uparrow$	5			0			
T_A	Operating free-air temperature		–55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		SN54ALS193A			SN74ALS193A			UNIT
				MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}		V_{CC} = 4.5 V,	I_I = –18 mA			–1.5			–1.5	V
V_{OH}		V_{CC} = 4.5 V to 5.5 V,	I_{OH} = –0.4 mA	V_{CC} – 2			V_{CC} – 2			V
V_{OL}		V_{CC} = 4.5 V	I_{OL} = 4 mA		0.25	0.4		0.25	0.4	V
			I_{OL} = 8 mA					0.35	0.5	
I_I		V_{CC} = 5.5 V,	V_I = 7 V			0.1		0.35	0.1	mA
I_{IH}		V_{CC} = 5.5 V,	V_I = 2.7 V			20			20	µA
I_{IL}	UP or DOWN	V_{CC} = 5.5 V,	V_I = 0.4 V			–0.2			–0.2	mA
	All others					–0.1			–0.1	
I_O§		V_{CC} = 5.5 V,	V_O = 2.25 V	–20		–112	–30		– 112	mA
I_{CC}		V_{CC} = 5.5 V,	See Note 1		12	22		12	22	mA

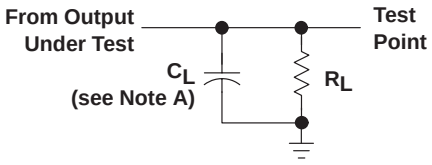
‡ All typical values are at V_{CC} = 5 V, T_A = 25°C.
§ The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, I_{OS}.
NOTE 1: I_{CC} is measured with the clear and load inputs grounded and all other inputs at 4.5 V.

switching characteristics (see Figure 1)

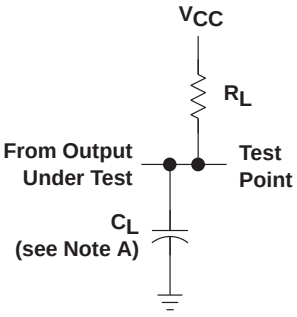
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R1 = R2 = 500 Ω, T_A = MIN to MAX†				UNIT
			SN54ALS193A		SN74ALS193A		
			MIN	MAX	MIN	MAX	
f_{max}			25		30		MHz
t_{PLH}	UP	$\overline{CO}$	3	20	3	16	ns
t_{PHL}			3	21	5	18	
t_{PLH}	DOWN	$\overline{BO}$	4	20	4	16	ns
t_{PHL}			5	22	5	18	
t_{PLH}	UP or DOWN	Any Q	3	27	3	19	ns
t_{PHL}			4	23	4	17	
t_{PLH}	$\overline{LOAD}$	Any Q	7	38	7	30	ns
t_{PHL}			8	37	8	28	
t_{PHL}	CLR	Any Q	5	20	5	17	ns

† For conditions shown MIN or MAX, use the appropriate value specified under recommended operating conditions.

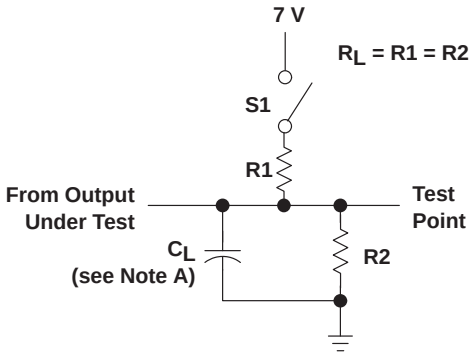
PARAMETER MEASUREMENT INFORMATION
SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



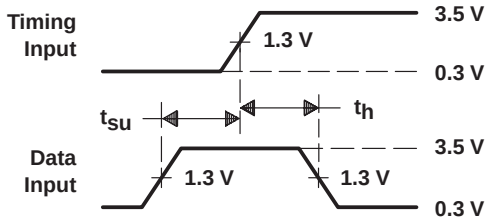
LOAD CIRCUIT FOR
BI-STATE
TOTEM-POLE OUTPUTS



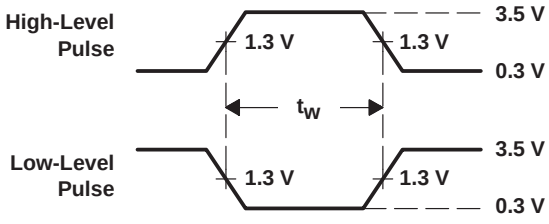
LOAD CIRCUIT
FOR OPEN-COLLECTOR OUTPUTS



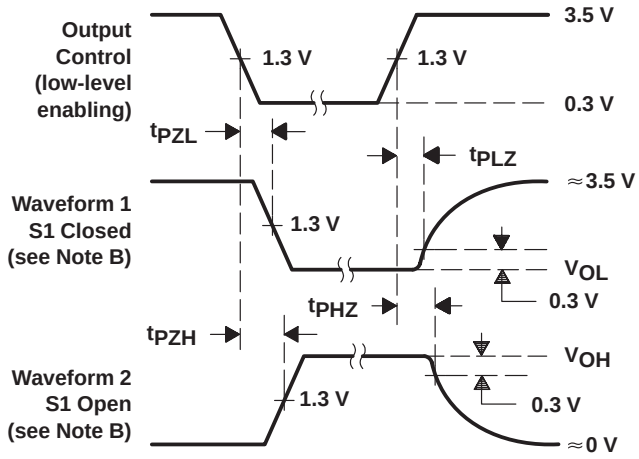
LOAD CIRCUIT
FOR 3-STATE OUTPUTS



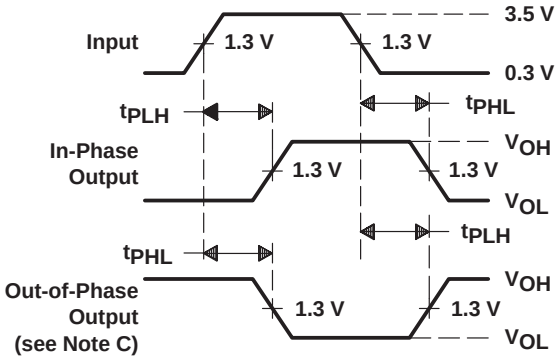
VOLTAGE WAVEFORMS
SETUP AND HOLD TIMES



VOLTAGE WAVEFORMS
PULSE DURATIONS



VOLTAGE WAVEFORMS
ENABLE AND DISABLE TIMES, 3-STATE OUTPUTS



VOLTAGE WAVEFORMS
PROPAGATION DELAY TIMES

NOTES: A. C_L includes probe and jig capacitance.
B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
D. All input pulses have the following characteristics: PRR ≤ 1 MHz, $t_r = t_f = 2$ ns, duty cycle = 50%.
E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms

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